INVENTOR, I hereby declare that:	
address and citizenship are as stated next to	my name.
inal, first and sole (if only one name is listed the subject matter which is claimed and for w	below), or an original, first and joint inventor (thich a patent is sought on the invention entitled
OVERLAY MEASUREMENT IN EXPOS	SURE PROCESS
attached hereto or indicates an attorney doc	ket no. <u>8107-1 (S03US005)</u> , or:
Trademark Office on <u>12/29/03</u> an	d assigned Serial No. 10/748,855
ed on	
referred to above. I acknowledge the duty on of this application in accordance with Title its under Title 35, U.S. Code §119(a)-(d) or § any PCT international application which des	ove-identified specification, including the claim y to disclose information which is material to 37 of the Code of Federal Regulations §1.56. §365(b) of any foreign application(s) for patent or ignated at least one country other than the United patent or inventor's certificate having a filing data
KOBEV	9 January 2003
(Country)	(Day/Month/Year filed
	address and citizenship are as stated next to sinal, first and sole (if only one name is listed the subject matter which is claimed and for we overlap MEASUREMENT IN EXPOSE attached hereto or indicates an attorney document of the above of the subject of the above of this application in accordance with Title its under Title 35, U.S. Code §119(a)-(d) or § any PCT international application which desidentified below any foreign applications for phich priority is claimed:

te insofar as the subject matter of each of the claims of this application is not disclosed in the prior United States or PC International application(s) in the manner provided by the first paragraph of Title 35, U.S. Code, §112, I acknowledge the duty t disclose information material to patentability as defined in Title 37, The Code of Federal Regulations, §1.56(a) which became available between the filing date of the prior application and the national or PCT international filing date of this application:

(Application Serial Number)

(Filing Date)

(STATUS: patented, pending, abandoned)

I hereby appoint the following attorneys: FRANK CHAU, Reg. No. 34,136; FRANK V. DeROSA, Reg. No. 43,584; NATHANIEL T. WALLACE, Reg. No. 48,909; ERIC M. PARHAM, Reg. No. 45,747; THOMAS W. McNALLY Reg. No. 48,609; MICHAEL F. MORANO, Reg. No. 44,952; KOON H. WONG, Reg. No. 48,459; and BENJAMIN M. HALPERN, Reg. No. 46,434; and each of them of F. CHAU & ASSOCIATES, LLP, 1900 Hempstead Turnpike, Suite 501 East Meadow, New York 11554 to prosecute this application and to transact all business in the U.S. Patent and Trademark Offic connected therewith and with any divisional, continuation, continuation-in-part, reissue or re-examination application, with fu power of appointment and with full power to substitute an associate attorney or agent, and to receive all patents which may issu thereon, and request that all correspondence be addressed to:

> Frank Chau, Esq. F. CHAU & ASSOCIATES, LLP 1900 Hempstead Turnpike, Suite 501 East Meadow, New York 11554 Area Code: 516-357-0091

I HEREBY DECLARE that all statements made herein of my own knowledge are true and that all statements made on informatic and belief are believed to be true; and further that these statements were made with the knowledge that willful false statements an the like so made are punishable by fine or imprisonment, or both, under §1001 of Title 18 U.S. Code and that such willful fals statements may jeopardize the validity of the application or any patent issued thereon.

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